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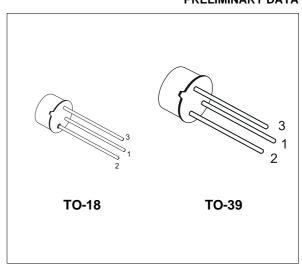


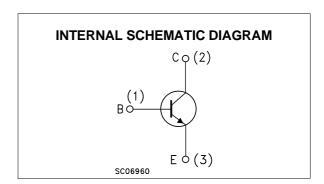
HIGH SPEED SWITCHES

PRELIMINARY DATA

DESCRIPTION

The 2N2219A and 2N2222A are silicon Planar Epitaxial NPN transistors in Jedec TO-39 (for 2N2219A) and in Jedec TO-18 (for 2N2222A) metal case. They are designed for high speed switching application at collector current up to 500mA, and feature useful current gain over a wide range of collector current, low leakage currents and low saturation voltage.





ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
|------------------|-------------------------------------------------------------------------------------------------------------|------------------------|-------------|
| Vсво | Collector-Base Voltage (I _E = 0) | 75 | V |
| V _{CEO} | Collector-Emitter Voltage (I _B = 0) | 40 | V |
| V_{EBO} | Emitter-Base Voltage (I _C = 0) | 6 | V |
| Ic | Collector Current | 0.6 | А |
| I _{CM} | Collector Peak Current (t _p < 5 ms) | 0.8 | Α |
| P _{tot} | Total Dissipation at $T_{amb} \le 25$ °C for 2N2219A for 2N2222A at $T_C \le 25$ °C for 2N2219A for 2N2222A | 0.8 0.5 3 1.8 | W W W |
| T _{stg} | Storage Temperature | -65 to 175 | °C |
| Tj | Max. Operating Junction Temperature | 175 | °C |

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THERMAL DATA

| | | | TO-39 | TO-18 | |
|-----------------------|-------------------------------------|-----|-------|-------|------|
| R _{thj-case} | Thermal Resistance Junction-Case | Max | 50 | 83.3 | °C/W |
| R _{thj-amb} | Thermal Resistance Junction-Ambient | Max | 187.5 | 300 | °C/W |

ELECTRICAL CHARACTERISTICS ($T_{case} = 25$ $^{\circ}C$ unless otherwise specified)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|-----------------------|----------------------------------------------------------------|------------------------------------------------------------------------------------------------------|-----------------------------------|------|------------|----------|
| I _{CBO} | Collector Cut-off Current (I _E = 0) | $V_{CB} = 60 \text{ V}$ $V_{CB} = 60 \text{ V}$ $T_j = 150 \text{ °C}$ | | | 10 10 | nΑ μΑ |
| I _{CEX} | Collector Cut-off Current (V _{BE} = -3V) | V _{CE} = 60 V | | | 10 | nA |
| I _{BEX} | Base Cut-off Current (V _{BE} = -3V) | VCE = 60 V | | | 20 | nA |
| I _{EBO} | Emitter Cut-off Current (I _C = 0) | V _{EB} = 3 V | | | 10 | nA |
| V _{(BR)CBO} | Collector-Base Breakdown Voltage (I _E = 0) | I _C = 10 μA | 75 | | | V |
| V _{(BR)CEO*} | Collector-Emitter Breakdown Voltage (I _B = 0) | I _C = 10 mA | 40 | | | V |
| V _{(BR)EBO} | Emitter-Base Breakdown Voltage (I _C = 0) | I _E = 10 μA | 6 | | | V |
| $V_{CE(sat)^*}$ | Collector-Emitter Saturation Voltage | $I_{C} = 150 \text{ mA}$ $I_{B} = 15 \text{ mA}$ $I_{C} = 500 \text{ mA}$ $I_{B} = 50 \text{ mA}$ | | | 0.3 1 | V V |
| $V_{BE(sat)^*}$ | Base-Emitter Saturation Voltage | $I_{C} = 150 \text{ mA}$ $I_{B} = 15 \text{ mA}$ $I_{C} = 500 \text{ mA}$ $I_{B} = 50 \text{ mA}$ | 0.6 | | 1.2 2 | V V |
| h _{FE} * | DC Current Gain | $\begin{array}{llllllllllllllllllllllllllllllllllll$ | 35 50 75 100 40 50 | | 300 | |
| h _{fe} * | Small Signal Current Gain | I _C = 1 mA | 50 75 | | 300 375 | |
| f⊤ | Transition Frequency | I _C = 20 mA V _{CE} = 20 V f = 100 MHz | | 300 | | MHz |
| СЕВО | Emitter-Base Capacitance | I _C = 0 V _{EB} = 0.5 V f = 100KHz | | | 25 | pF |
| Ссво | Collector-Base Capacitance | I _E = 0 V _{CB} = 10 V f = 100 KHz | | | 8 | pF |
| R _{e(hie)} | Real Part of Input Impedance | I _C = 20 mA V _{CE} = 20 V f = 300MHz | | | 60 | Ω |

^{*} Pulsed: Pulse duration = 300 μs, duty cycle ≤ 1 %

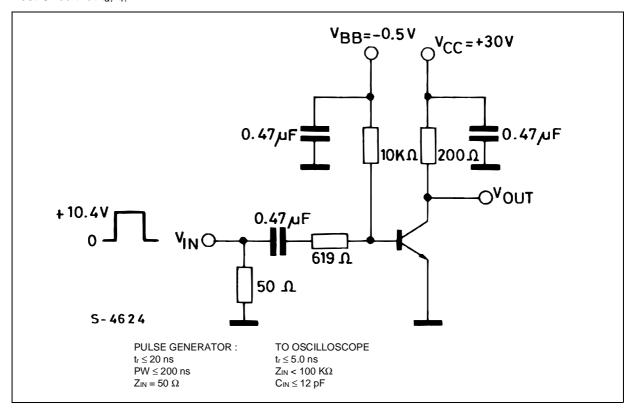
ELECTRICAL CHARACTERISTICS (continued)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|-----------------------------------|---------------------------|--------------------------------------------------------------------------------------------------------|-----------|------|-----------|--------------------------------------|
| NF | Noise Figure | $I_C = 0.1 \text{ mA}$ $V_{CE} = 10 \text{ V}$ $f = 1 \text{KHz}$ $R_g = 1 \text{K}\Omega$ | | 4 | | dB |
| h _{ie} | Input Impedance | $I_{C} = 1 \text{ mA}$ $V_{CE} = 10 \text{ V}$ $I_{C} = 10 \text{ mA}$ $V_{CE} = 10 \text{ V}$ | 2 0.25 | | 8 1.25 | kΩ kΩ |
| h _{re} | Reverse Voltage Ratio | I _C = 1 mA V _{CE} = 10 V I _C = 10 mA V _{CE} = 10 V | | | 8 4 | 10 ⁻⁴ 10 ⁻⁴ |
| h _{oe} | Output Admittance | I _C = 1 mA V _{CE} = 10 V I _C = 10 mA V _{CE} = 10 V | 5 25 | | 35 200 | μS μS |
| t _d ** | Delay Time | $V_{CC} = 30 \text{ V}$ $I_{C} = 150 \text{ mA}$ $I_{B1} = 15 \text{ mA}$ $V_{BB} = -0.5 \text{ V}$ | | | 10 | ns |
| t _r ** | Rise Time | V _{CC} = 30 V I _C = 150 mA I _{B1} = 15 mA V _{BB} = -0.5 V | | | 25 | ns |
| t _s ** | Storage Time | $V_{CC} = 30 \text{ V}$ $I_{C} = 150 \text{ mA}$ $I_{B1} = -I_{B2} = 15 \text{ mA}$ | | | 225 | ns |
| t _f ** | Fall Time | V _{CC} = 30 V I _C = 150 mA I _{B1} = -I _{B2} = 15 mA | | | 60 | ns |
| r _{bb'} C _{b'c} | Feedback Time Constant | I _C = 20 mA V _{CE} = 20 V f = 31.8MHz | | | 150 | ps |

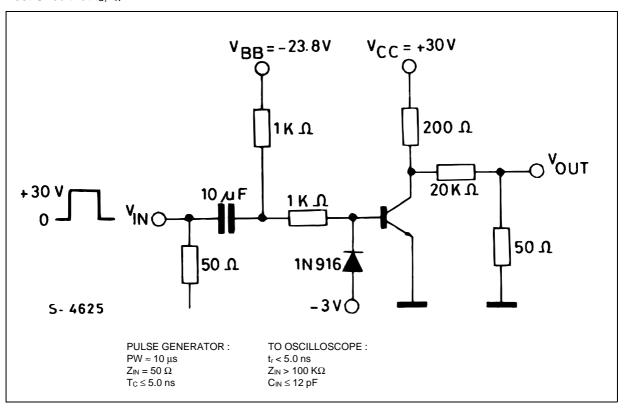
^{*} Pulsed: Pulse duration = 300 μs, duty cycle ≤ 1 %

** See test circuit

Test Circuit fot t_d, t_{r.}

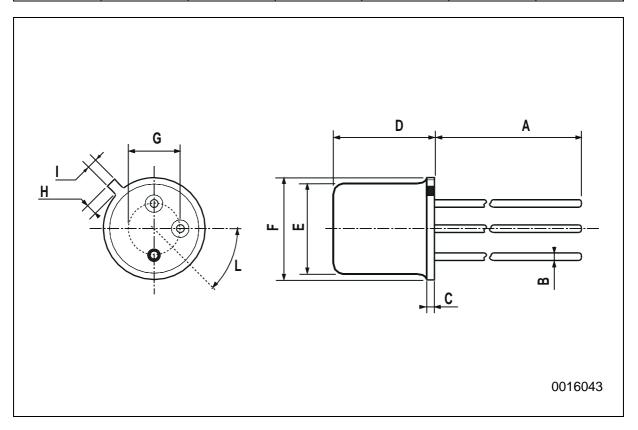


Test Circuit fot td, tr.



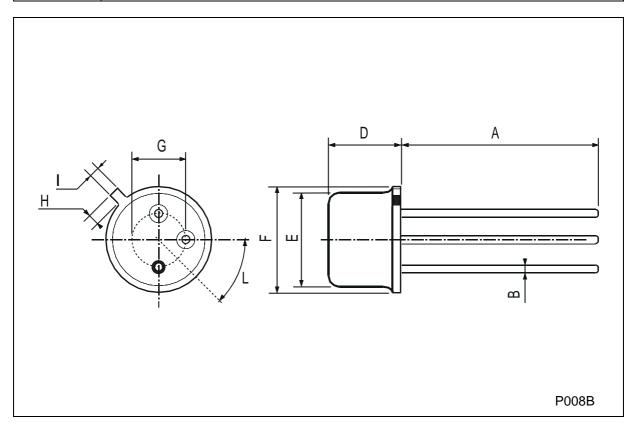
TO-18 MECHANICAL DATA

| DIM. | mm | | | inch | | |
|------|------|------|------|-------|-------|-------|
| | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| А | | 12.7 | | | 0.500 | |
| В | | | 0.49 | | | 0.019 |
| D | | | 5.3 | | | 0.208 |
| E | | | 4.9 | | | 0.193 |
| F | | | 5.8 | | | 0.228 |
| G | 2.54 | | | 0.100 | | |
| Н | | | 1.2 | | | 0.047 |
| I | | | 1.16 | | | 0.045 |
| L | 45° | | | 45° | | |



TO-39 MECHANICAL DATA

| DIM. | mm | | inch | | | |
|------|------------|------|------|-------|------|-------|
| | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| А | 12.7 | | | 0.500 | | |
| В | | | 0.49 | | | 0.019 |
| D | | | 6.6 | | | 0.260 |
| E | | | 8.5 | | | 0.334 |
| F | | | 9.4 | | | 0.370 |
| G | 5.08 | | | 0.200 | | |
| Н | | | 1.2 | | | 0.047 |
| ı | | | 0.9 | | | 0.035 |
| L | 45° (typ.) | | | | | |



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